

Search Notes

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Examiner

John Q. Nguyen

Applicant(s)/Patent under
Reexamination

AARON ET AL.

Art Unit

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SEARCHED

Class	Subclass	Date	Examiner
Previous	Search updated	7/31/2007	/JN/

INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

**SEARCH NOTES
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR